GKS-075 214 064 A 2000

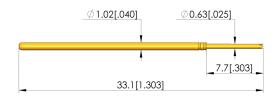
Item GKS-075-0007





- Well-established test probes for contacting PCBs
- For optimal contact to the test points (e.g. pads, vias, and pins), various tip styles with various diameters and finishes are available.
- · Various spring forces available as well as versions with stainless steel springs suitable for high temperatures
- Used for setting the optimum stroke conditions in the test fixture, various installation heights can be achieved by combining test probes and receptacles







General data

Product group: ICT / FCT (in-circuit test and function test Sub-product group: Standard stroke test probe GKS-075 Series: 1.91 mm [75.1 mil] Grid: Contacting from: Pad Magnetic: Yes Installation type: Plug-in Quick-exchange system: Yes Adjustable installation height: No Non-rotating: No Compatible receptacle(s): KS-075 Min. temperature: -40 °C [-40 °F] Max. temperature: 80 °C [176 °F] RoHS-compliant:

Tip style data

14 4-point crown, self-cleaning
0.64 mm [.025 in]
A gold
2 steel

Electrical data

Current load capacity / rated current:	3 A
Typical resistance (Ri):	20 mOhm

Mechanical data

Weer arrical data	
Total length:	33.1 mm [1.3 in]
Barrel diameter:	1.02 mm [.04 in]
Maximum stroke:	6.35 mm [.25 in]
Spring pre-load:	0.72 N [2.58 ozf]
Collar height:	0
Spring force at working stroke:	2 N [7.19 ozf]
Recommended working stroke:	4.3 mm [.169 in]

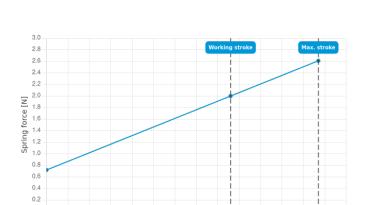
Partner for Future Technology

Test Probe GKS-075 214 064 A 2000

Item GKS-075-0007

0.5 1.0 1.5 2.0 2.5





3.0 3.5

Stroke [mm]

4.0 4.5 5.0 5.5 6.0 6.5

INGUN Prüfmittelbau GmbH

Max-Stromeyer-Straße 162 78467, Constance, Germany Phone +49 7531 8105-0 Customer hotline +49 7531 8105-888 Fax +49 7531 8105-65 info@ingun.com









Learn more about **ICT/FCT Test probes**

